

Photoelectrochemical properties of cadmium chalcogenide sensitized textured porous zinc oxide plate electrodes

Supporting Information

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1. Calculation of theoretical photocurrent of ZnO/CdSe PEC.

Figure S1 shows the terrestrial reference solar spectrum (ASTM G-173-3),¹ where the spectral irradiance, $P_\lambda(\lambda)$ ($\text{mW cm}^{-2} \text{ nm}^{-1}$), is plotted as a function of the wavelength, λ . From the spectral irradiance it can be calculated the photon flux at the Earth's surface via the following relation

$$P_T \int_0^\infty P_\lambda(\lambda) d\lambda \quad (\text{S1})$$

and integration of this equation in the range from 280 to 4000 nm yields 100 mW/cm^2 (AM 1.5 G). It is more convenient to use number of photons instead of incident energy. The relation between incident photon flux, $I_\lambda(\lambda)$ ($\text{photons cm}^{-2} \text{ nm}^{-1} \text{ s}^{-1}$), and spectral irradiance is given by

$$I_\lambda(\lambda) = \frac{P_\lambda(\lambda)\lambda}{hc} \quad (\text{S2})$$

where h is the Planck's constant and c is the speed of light in a vacuum. By knowing the IPCE and $I_\lambda(\lambda)$ values at the corresponding wavelength the photocurrent density, $J_\lambda(\lambda)$ ($\text{mA cm}^{-2} \text{ nm}^{-1}$) can be calculated

$$J_\lambda = \text{IPCE}(\lambda) I_\lambda(\lambda) e \quad (\text{S3})$$

where e is the charge of an electron. Figure S1 shows the values of $J_\lambda(\lambda)$ vs. λ for CdSe-sensitized ZnO plate electrode. In order to relate $J_\lambda(\lambda)$ to our experimental data it is more convenient to calculate the photocurrent density to the threshold wavelength λ_{th} that can be calculated via the following integral

$$J_T = \int_0^{\lambda_{\text{th}}} J(\lambda) d\lambda \quad (\text{S4})$$

Figure 8 shows calculated J_T curve of CdSe-sensitized ZnO electrodes with a maximum value equal to 6.5 mA/cm^2 . This value is much higher than the one obtained for ZnO and ZnO/CdS electrodes, which are 0.9 and 2.5 mA/cm^2 , respectively. Comparing the experimental and

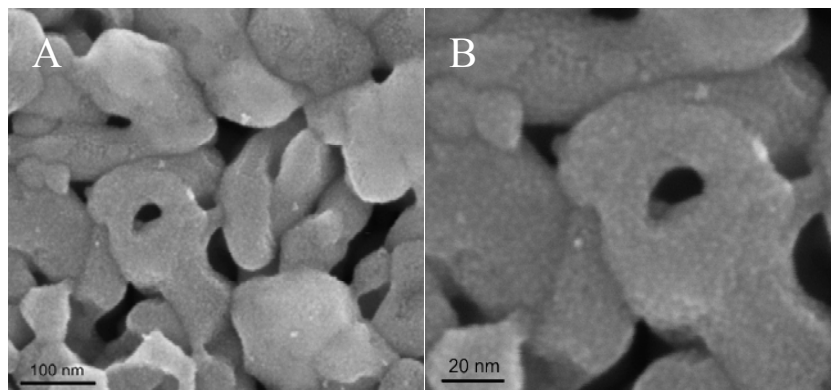


Figure S3. SEM images of ZnO/CdS plates at different magnifications.

4. Diffuse reflectance spectra of ZnO plates illuminated in front and back configuration

Figure S4 shows the IPCE and diffuse reflectance spectra of ZnO plates illuminated in front and back configuration. The IPCE values for the cell illuminated from the front-side are lower than under back-side illumination. Upon front-side illumination of the ZnO film, most of the charge carriers were generated relatively far from the FTO substrate. This means they have to travel longer distances than under back-side illumination conditions. A lower front-side photocurrent therefore indicates that electron transport is limiting the overall photocurrent.²⁻⁴ The difference in front- vs. back-side photocurrents cannot be attributed to lower light absorption under front-side illumination, for example due to light scattering effects. As shown in Fig. S4b, the diffuse reflectance under front-side illumination is lower than under back-side illumination, which means that the corresponding absorption is actually higher. Finally, we note that for these porous electrodes, no conclusions can be drawn on hole transport from front- vs. back-side illumination experiments; the distance that the holes have to travel to reach the electrolyte is the same in both cases.

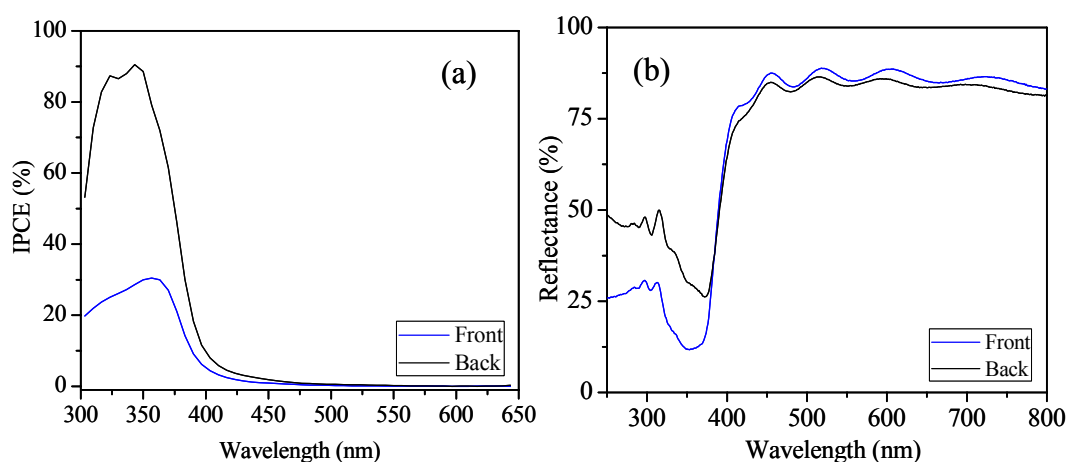


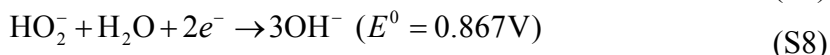
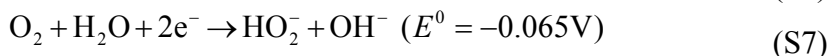
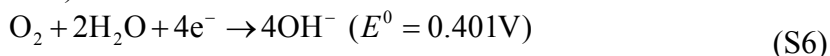
Figure S4. (a) IPCE and (b) diffuse reflectance spectra of ZnO plates illuminated in front and back configuration.

5. Possible alternative reactions in the presence of O₂

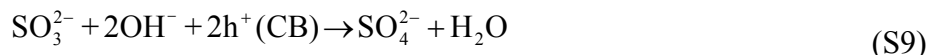
Since we did not purge the solution with inert gas, small amounts of dissolved oxygen gas may be present in the solution. This may lead to the homogeneous oxidation of a small fraction of the sulfite to sulfate:



In alkaline aqueous solution the following sets of equations may proceed upon photoexcitation of the semiconductors (ZnO, CdS or CdSe):⁵



The potentials are given with respect to the normal hydrogen electrode (NHE). It is obvious that the formation of OH^- will maintain the alkalinity of the solutions, which eventually will facilitate the following reaction:



By removing any dissolved oxygen through purging, reactions (S5-S8) can be suppressed.

References

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